## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10775629	ZEIRA ET AL.
Examiner	Art Unit
Hanh Nguyen	2616

SEARCHED					
Class	Subclass	Date	Examiner		
370	252	4/22/08	hn		
	253				
	332				
	333				
	468				
	395.21				
	395.4				
	335				
370	432				
455	135				
	452.1				
	403				
	423				
	456.2				
455	134	4/22/08	hn		

SEARCH NOTES				
Search Notes	Date	Examiner		
East	4/22/08	HN		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
370	333	4/22/08	HN		
	468				
370	395.21				
455	135				
455	452.1	4/22/08	hn		

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